

Search Notes

Application/Control No.

10/049,456

Examiner

Rene Towa

Applicant(s)/Patent under
Reexamination

LURIE ET AL.

Art Unit

3736

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 600 | 562 | 6/21/2006 | RTT |
| 600 | 563 | 6/21/2006 | RTT |
| 600 | 570 | 6/21/2006 | RTT |
| 600 | 571 | 6/21/2006 | RTT |
| 600 | 573 | 6/21/2006 | RTT |
| 600 | 576 | 6/21/2006 | RTT |
| 600 | 578 | 6/21/2006 | RTT |
| 600 | 581 | 6/21/2006 | RTT |
| 604 | 192 | 6/21/2006 | RTT |
| 604 | 195 | 6/21/2006 | RTT |
| 604 | 196 | 6/21/2006 | RTT |
| 604 | 197 | 6/21/2006 | RTT |
| 604 | 198 | 6/21/2006 | RTT |
| 604 | 218 | 6/21/2006 | RTT |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------------|-----------|------|
| SEE SEARCH NOTES | 6/21/2006 | RTT |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |